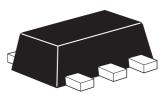


# **ZXTN19020DZ** 20V NPN high gain transistor in SOT89

## Summary

 $BV_{CEX} > 70V$   $BV_{CEO} > 20V$   $BV_{ECO} > 4.5V$   $I_{C(cont)} = 7.5A$   $V_{CE(sat)} < 35mV @ 1A$   $R_{CE(sat)} = 21m\Omega$  $P_D = 2.4W$ 



### Complementary part number ZXTP19020DZ

### Description

Packaged in the SOT89 outline this new low saturation NPN transistor offers extremely low on state losses making it ideal for use in DC-DC circuits and various driving and power management functions.

### Features

- 7.5A continuous current
- Up to 20A peak current
- Very low saturation voltage
- 70V forward blocking voltage
- 4.5V reverse blocking voltage

### Applications

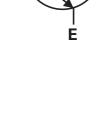
- Emergency lighting circuits
- Motor driving
- Camera strobe
- Boost converter
- CCFL backlight inverters
- MOSFET gate drivers
- LED Driving

### **Ordering information**

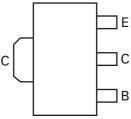
Device	Reel size	Tape width	Quantity
	(inches)	(mm)	per reel
ZXTN19020DZTA	7	12	1000

### **Device marking**

1L8



С



Pinout - top view

## Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Collector-Base voltage	V <sub>CBO</sub>	70	V
Collector-Emitter voltage (forward blocking)	V <sub>CEX</sub>	70	V
Collector-Emitter voltage	V <sub>CEO</sub>	20	V
Emitter-Collector voltage (reverse blocking)	V <sub>ECX</sub>	6	V
Emitter-Base voltage	V <sub>EBO</sub>	7	V
Continuous Collector current <sup>(c)</sup>	۱ <sub>C</sub>	7.5	А
Base current	ا <sub>B</sub>	1	А
Peak pulse current	I <sub>CM</sub>	20	А
Power dissipation at $T_A = 25^{\circ}C^{(a)}$	PD	1.1	W
Linear derating factor		8.8	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(b)}$	PD	1.8	W
Linear derating factor		14.4	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(c)}$	PD	2.4	W
Linear derating factor		19.2	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(d)}$	PD	4.46	W
Linear derating factor		35.7	mW/°C
Power dissipation at $T_{C} = 25^{\circ}C^{(e)}$	PD	27.8	W
Linear derating factor		222	mW/°C
Operating and storage temperature range	T <sub>j</sub> , T <sub>stg</sub>	-55 to 150	°C

### **Thermal resistance**

Parameter	Symbol	Limit	Unit	
Junction to ambient <sup>(a)</sup>	R <sub>0JA</sub>	117	°C/W	
Junction to ambient <sup>(b)</sup>	R <sub>0JA</sub>	68	°C/W	
Junction to ambient <sup>(c)</sup>	R <sub>0JA</sub>	51	°C/W	
Junction to ambient <sup>(d)</sup>	$R_{\Theta JA}$	28	°C/W	
Junction to case <sup>(e)</sup>	$R_{\Theta JC}$	4.69	°C/W	

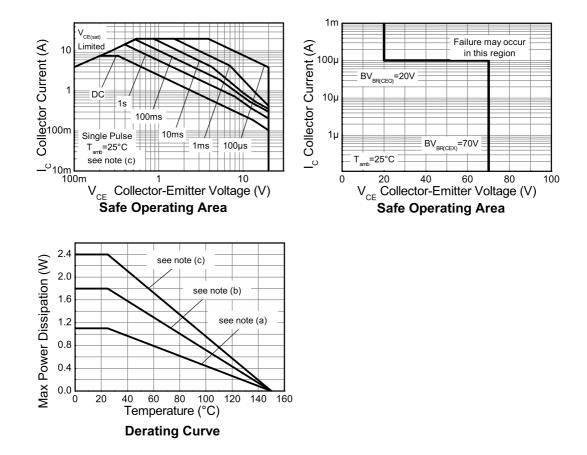
NOTES:

(a) For a device surface mounted on 15mm x 15mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

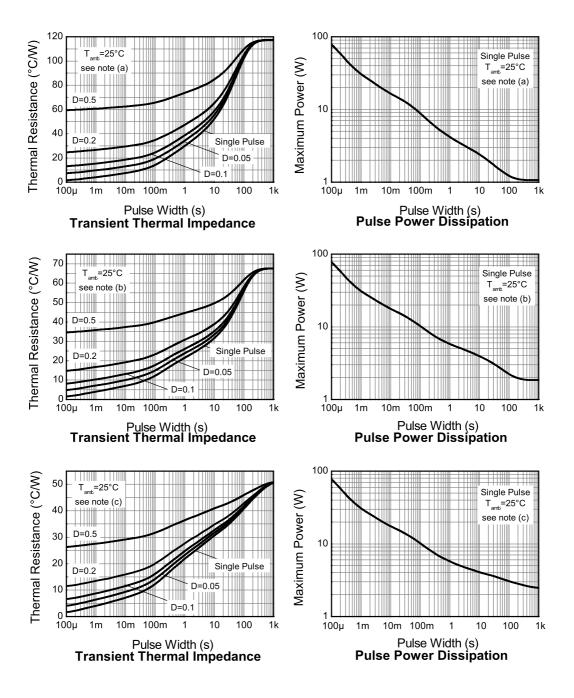
(b) Mounted on 25mm x 25mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions. (c) Mounted on 50mm x 50mm x 0.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions. (d) As (c) above measured at t<5 seconds.

(e) Junction to case (collector tab). Typical

## **Thermal characteristics**



## **Thermal characteristics**



Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-Base breakdown voltage	BV <sub>CBO</sub>	70	100		V	I <sub>C</sub> = 100μA
Collector-Emitter breakdown voltage (forward blocking)	BV <sub>CEX</sub>	70	100		V	$I_C$ = 100µA, $R_{BE} \leq 1 k \Omega$ or $-1V < V_{BE} < 0.25V$
Collector-Emitter breakdown voltage	BV <sub>CEO</sub>	20	30		V	I <sub>C</sub> = 10mA <sup>(*)</sup>
Emitter-Collector breakdown voltage (reverse blocking)	BV <sub>ECX</sub>	6	8.4		V	$I_{E} = 100 \mu A, R_{BC} \le 1 k \Omega \text{ or}$ 0.25V > V_{BC} > -0.25V
Emitter-Collector breakdown voltage (reverse blocking)	BV <sub>ECO</sub>	4.5	5.7		V	I <sub>E</sub> = 100μA
Emitter-Base breakdown voltage	BV <sub>EBO</sub>	7.0	8.4		V	I <sub>E</sub> = 100μA
Collector-Base cut-off	I <sub>CBO</sub>		<1	50	nA	V <sub>CB</sub> = 70V
current				0.5	μA	V <sub>CB</sub> = 70V, T <sub>amb</sub> =100°C
Collector-Emitter cut-off current	I <sub>CEX</sub>			100	nA	$V_{CE}$ = 70V, $R_{BE} \le 1k\Omega$ or -1V < $V_{BE}$ < 0.25V
Emitter cut-off current	I <sub>EBO</sub>		<1	50	nA	V <sub>EB</sub> = 5.6V
Collector-Emitter	$V_{CE(sat)}$		26	32	mV	I <sub>C</sub> = 1A, I <sub>B</sub> = 100mA <sup>(*)</sup>
saturation voltage			50	70	mV	$I_{\rm C} = 1$ A, $I_{\rm B} = 10$ mA <sup>(*)</sup>
			75	100	mV	$I_{\rm C} = 2A, I_{\rm B} = 20 {\rm m} {\rm A}^{(*)}$
			60	80	mV	$I_{C} = 2A, I_{B} = 40mA^{(*)}$
			83	105	mV	$I_{C} = 4A, I_{B} = 400 \text{mA}^{(*)}$
			155	200	mV	l <sub>C</sub> = 7.5A, l <sub>B</sub> = 375mA <sup>(*)</sup>
Base-Emitter saturation voltage	V <sub>BE(sat)</sub>		1000	1100	mV	I <sub>C</sub> = 7.5A, I <sub>B</sub> = 375mA <sup>(*)</sup>
Base-Emitter turn-on voltage	V <sub>BE(on)</sub>		870	1000	mV	$I_{C} = 7.5A, V_{CE} = 2V^{(*)}$
Static forward current	h <sub>FE</sub>	300	450	900		I <sub>C</sub> = 100mA, V <sub>CE</sub> = 2V <sup>(*)</sup>
transfer ratio		260	390			$I_{C} = 2A, V_{CE} = 2V^{(*)}$
		150	210			$I_{C} = 7.5A, V_{CE} = 2V^{(*)}$
		50	75			$I_{C} = 15A, V_{CE} = 2V^{(*)}$
			35			$I_{C} = 20A, V_{CE} = 2V^{(*)}$
Transition frequency	f <sub>T</sub>		160		MHz	I <sub>C</sub> = 50mA, V <sub>CE</sub> = 10V f = 100MHz
Input capacitance	C <sub>ibo</sub>		297	400	pF	V <sub>EB</sub> = 0.5V, f = 1MHz <sup>(*)</sup>
Output capacitance	C <sub>obo</sub>		32.6	40	pF	V <sub>CB</sub> = 10V, f = 1MHz <sup>(*)</sup>
Delay time	t <sub>d</sub>		129		ns	
Rise time	t <sub>r</sub>		96		ns	$I_{\rm C} = 1$ A, $V_{\rm CC} = 10$ V,
Storage time	t <sub>s</sub>		398		ns	I <sub>B1</sub> =-I <sub>B2</sub> = 10mA
Fall time	t <sub>f</sub>		90		ns	

## Electrical characteristics (at $T_{amb}$ = 25°C unless otherwise stated).

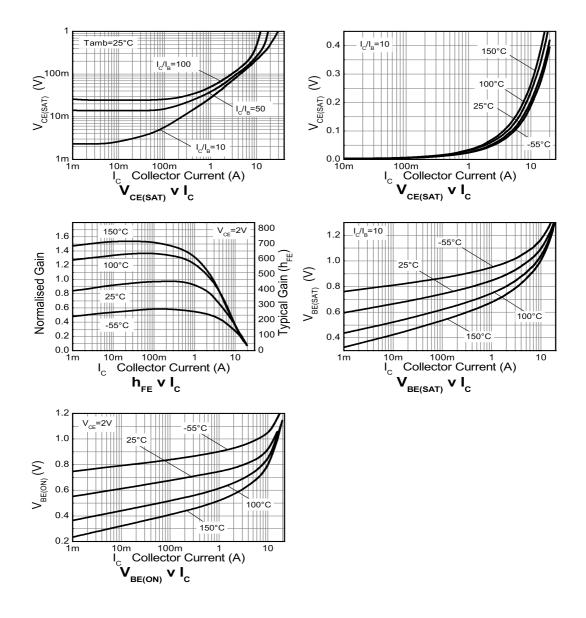
#### NOTES:

(\*) Measured under pulsed conditions. Pulse width  $\leq$  300µs; duty cycle  $\leq$  2%.

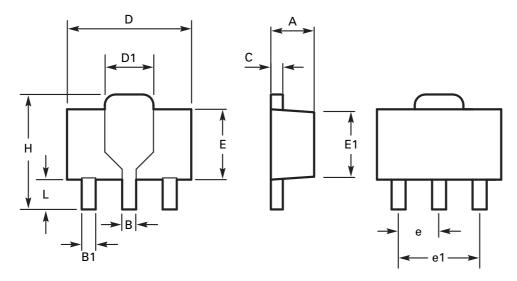
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## **Typical characteristics**



## Package outline - SOT89



DIM	Millin	neters	Inc	hes	DIM	Millimeters		Inches	
	Min	Max	Min	Max		Min	Max	Min	Max
А	1.40	1.60	0.550	0.630	E	2.29	2.60	0.090	0.102
В	0.44	0.56	0.017	0.022	E1	2.13	2.29	0.084	0.090
B1	0.36	0.48	0.014	0.019	е	1.50 BSC		0.059 BSC	
С	0.35	0.44	0.014	0.017	e1	3.00 BSC		0.118 BSC	
D	4.40	4.60	0.173	0.181	Н	3.94	4.25	0.155	0.167
D1	1.52	1.83	0.064	0.072	L	0.89	1.20	0.035	0.047

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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